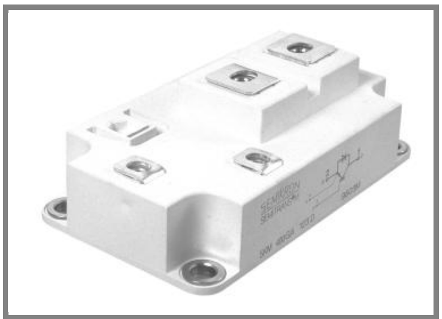
SKM 600GA125D



SEMITRANS[TM] 4

Ultra Fast IGBT Modules

SKM 600GA125D

Preliminary Data

Features

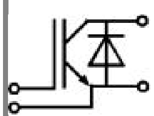
- NPT-IGBT with positive temperature coeffecient of V_{CEsat}
- Short circuit self limiting to 6 x I_c
- Corresponds to standards: IEC 60721-3-3 (humidity) class 3K3/IEC 68T.1 climate 40/125/56

Typical Applications

- Resonant inverters upto 100 kHz
- Inductive heating
- Electronic welders at f_{SW} >20 kHz

Remarks

- $I_{DC} \leq$ 500A limited by terminals
- Take care of over-voltage caused by stray inductances.



GA

Absolute Maximum Ratings		T_c = 25 °C, unless otherwise specified	
Symbol	**Conditions**	**Values**	**Units**
IGBT			
V_{CES}		1200	V
I_C	T_c = 25 (80) °C	580 (400)	A
I_{CRM}	t_p = 1 ms	800	A
V_{GES}		± 20	V
T_{vj}, (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	T_c = 25 (80) °C	500 (350)	A
I_{FRM}	t_p = 1 ms	800	A
I_{FSM}	t_p = 10 ms; sin.; T_j = 150 °C	3600	A

Characteristics			T_c = 25 °C, unless otherwise specified		
Symbol	**Conditions**	**min.**	**typ.**	**max.**	**Units**
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, I_C = 16 mA	4,5	5,5	6,5	V
I_{CES}	V_{GE} = 0, $V_{CE} = V_{CES}$, T_j = 25 (125) °C		0,15	0,45	mA
$V_{CE(TO)}$	T_j = 25 (125) °C		1,5 (1,7)	1,75	V
r_{CE}	V_{GE} = 15 V, T_j = 25 (125) °C		4,5 (6)	5,3	mΩ
$V_{CE(sat)}$	I_{Cnom} = 400 A, V_{GE} = 15 V, chip level		3,3 (4)	3,85	V
C_{ies}	under following conditions		36		nF
C_{oes}	V_{GE} = 0, V_{CE} = 25 V, f = 1 MHz		3,8		nF
C_{res}			3,5		nF
L_{CE}				20	nH
$R_{CC'+EE'}$	res., terminal-chip T_c= 25 (125) °C		0,18 (0,22)		mΩ
$t_{d(on)}$	V_{CC} = 600 V, I_{Cnom} = 400 A		80		ns
t_r	$R_{Gon} = R_{Goff}$ = 2,5 Ω, T_j = 125 °C		70		ns
$t_{d(off)}$	V_{GE} = ± 15 V		570		ns
t_f			60		ns
E_{on} (E_{off})			30 (22)		mJ
Inverse diode					
$V_F = V_{EC}$	I_{Fnom} = 400 A; V_{GE} = 0 V; T_j = 25 (125) °C		2 (1,8)	2,5	V
$V_{(TO)}$	T_j = 25 (125) °C			(1,2)	V
r_T	T_j = 25 (125) °C			(3)	mΩ
I_{RRM}	I_{Fnom} = 400 A; T_j = 125 ( ) °C		460		A
Q_{rr}	di/dt = 7200 A/µs		65		µC
E_{rr}	V_{GE} = 0 V		27		mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,041	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,09	K/W
$R_{th(c-s)}$	per module			0,038	K/W
Mechanical data					
M_s	to heatsink M6	3		5	Nm
M_t	to terminals M6 (M4)	2,5 (1,1)		5 (2)	Nm
w				330	g

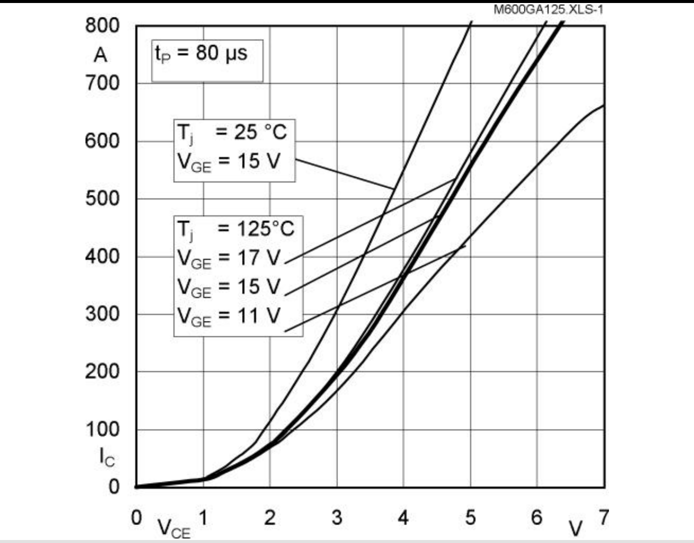


Fig. 1 Typ. output characteristic, inclusive $R_{CC'+ EE'}$

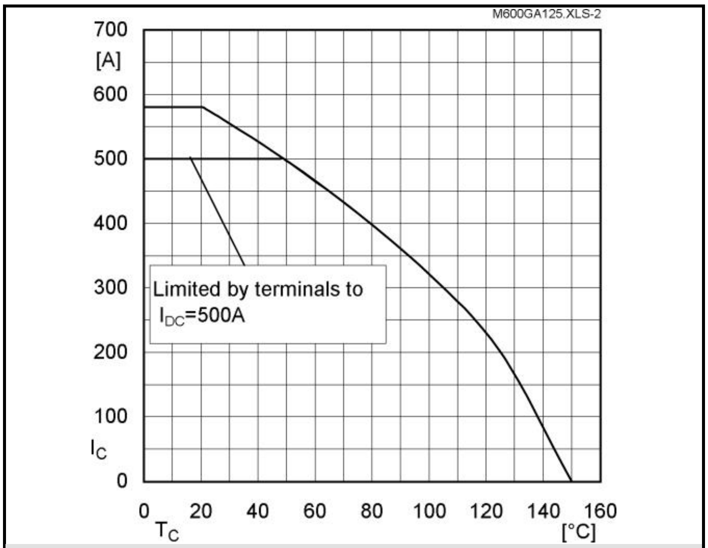


Fig. 2 Rated current vs. temperature $I_C = f (T_C)$

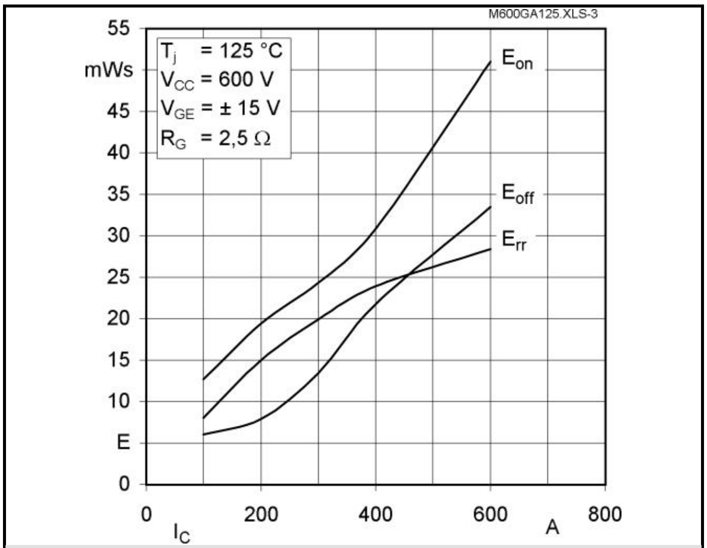


Fig. 3 Typ. turn-on /-off energy = f (I_C)

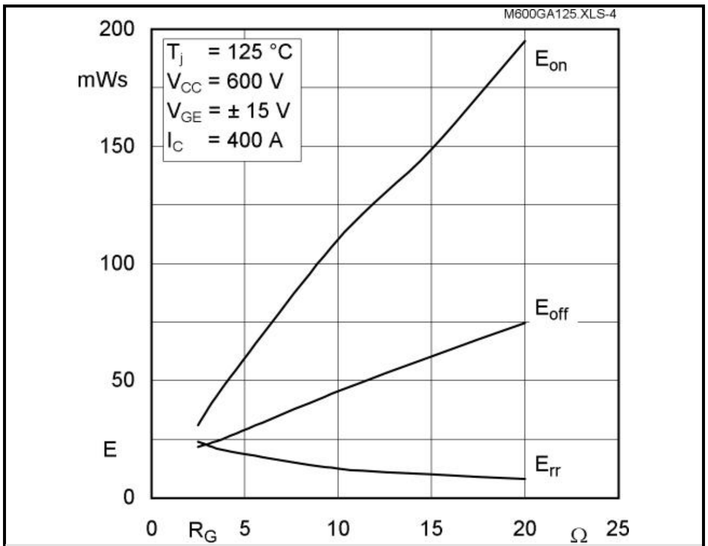


Fig. 4 Typ. turn-on /-off energy = f (R_G)

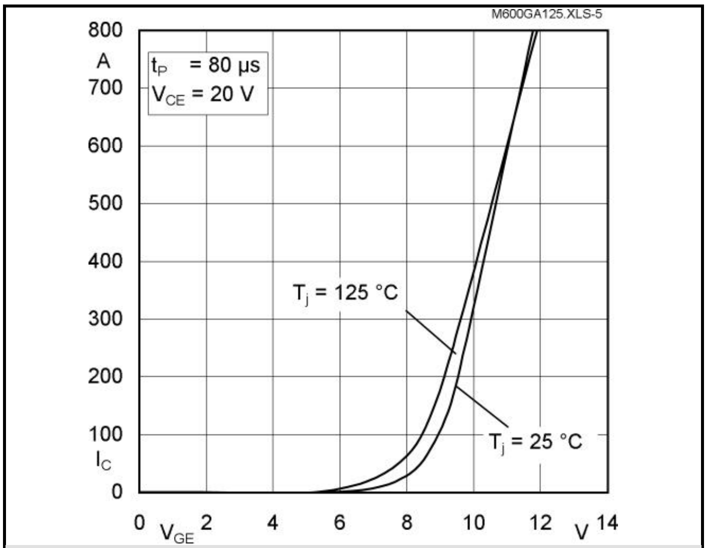


Fig. 5 Typ. transfer characteristic

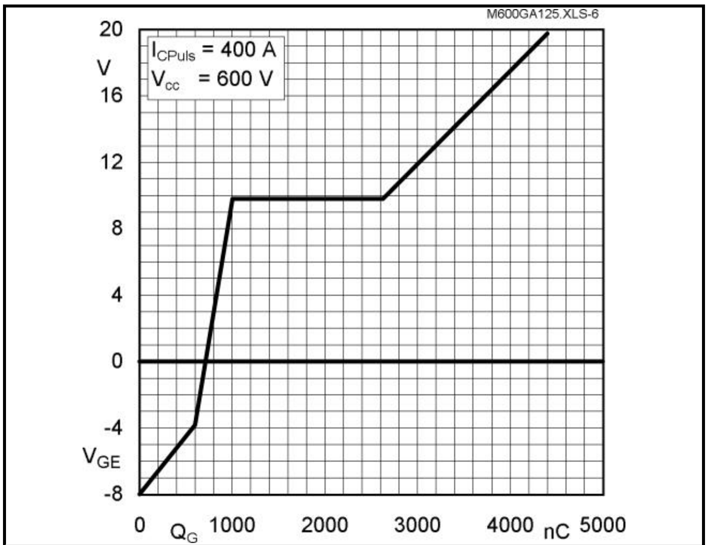


Fig. 6 Typ. gate charge characteristic

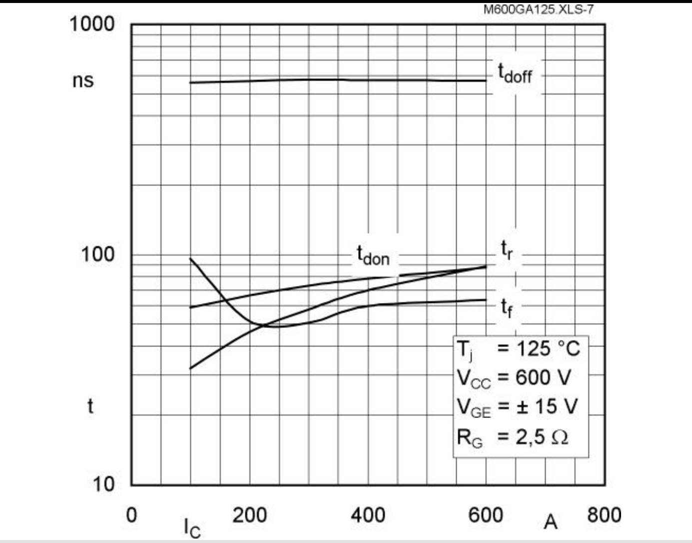


Fig. 7 Typ. switching times vs. I_C

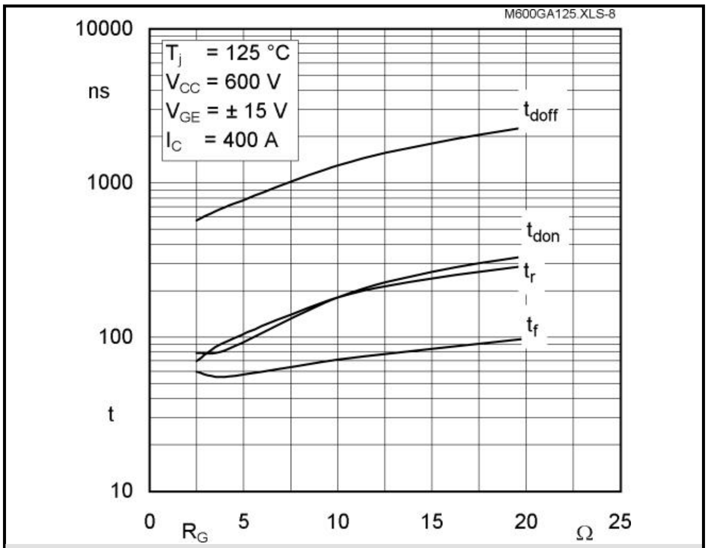


Fig. 8 Typ. switching times vs. gate resistor R_G

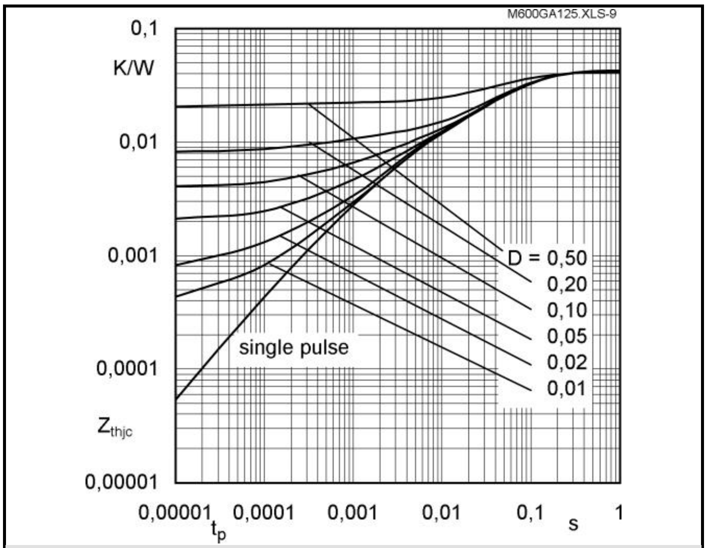


Fig. 9 Transient thermal impedance of IGBT

$Z_{thp(j-c)}$ = f (t_p); D = t_p/t_c = t_p*f

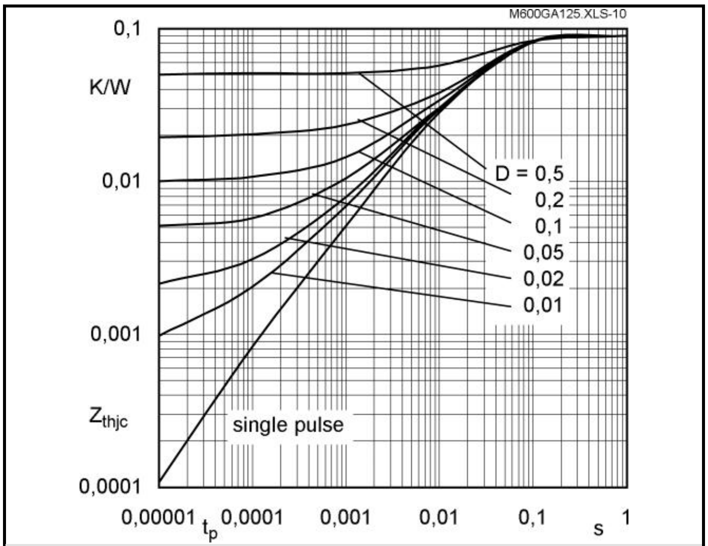


Fig. 10 Transient thermal impedance of Inverse CAL Diode

$Z_{thp(j-c)}$ = f (t_p); D = t_p/t_c = t_p*f

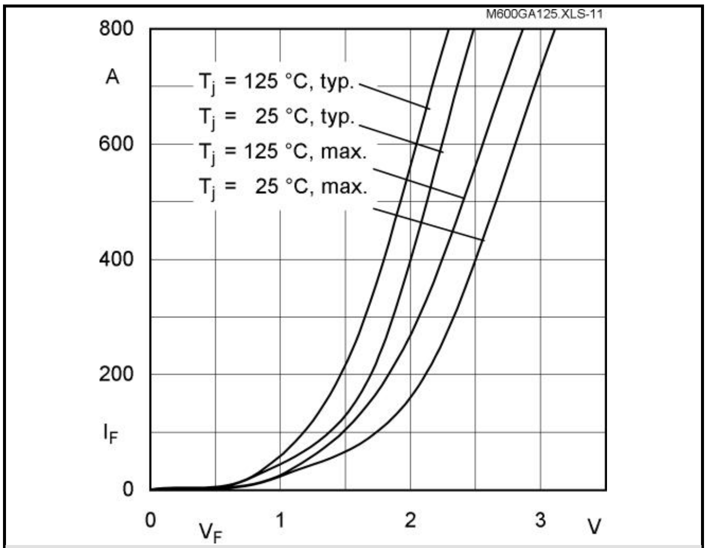


Fig. 11 CAL diode forward characteristic

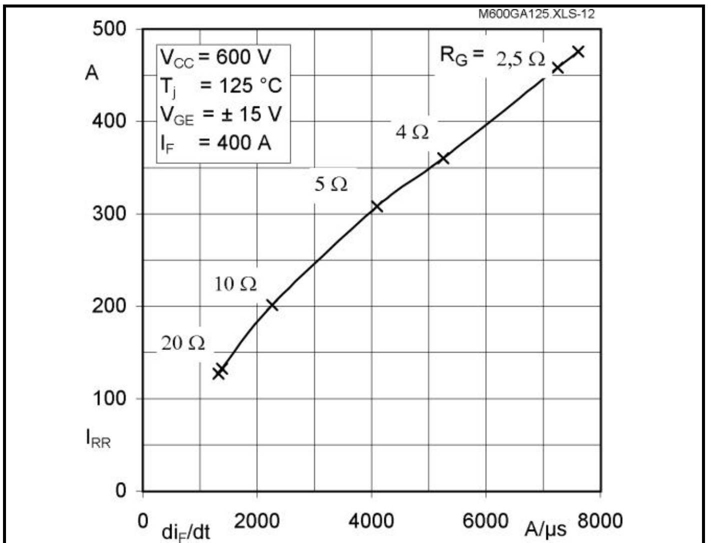


Fig. 12 Typ. CAL diode peak reverse recovery current

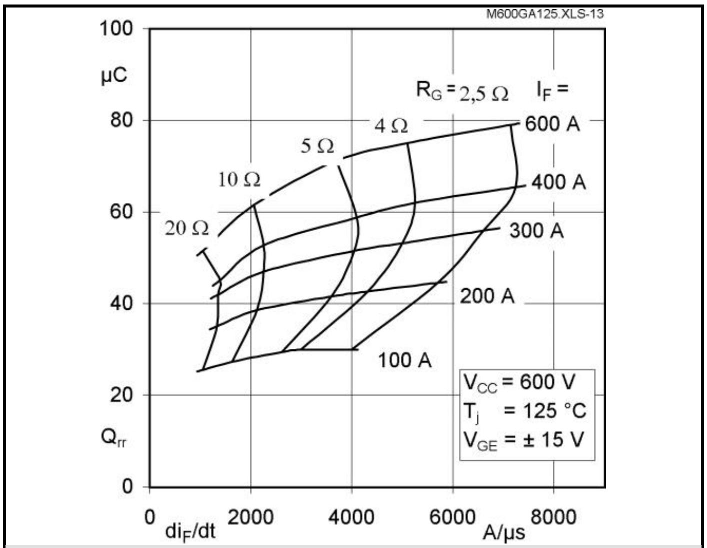
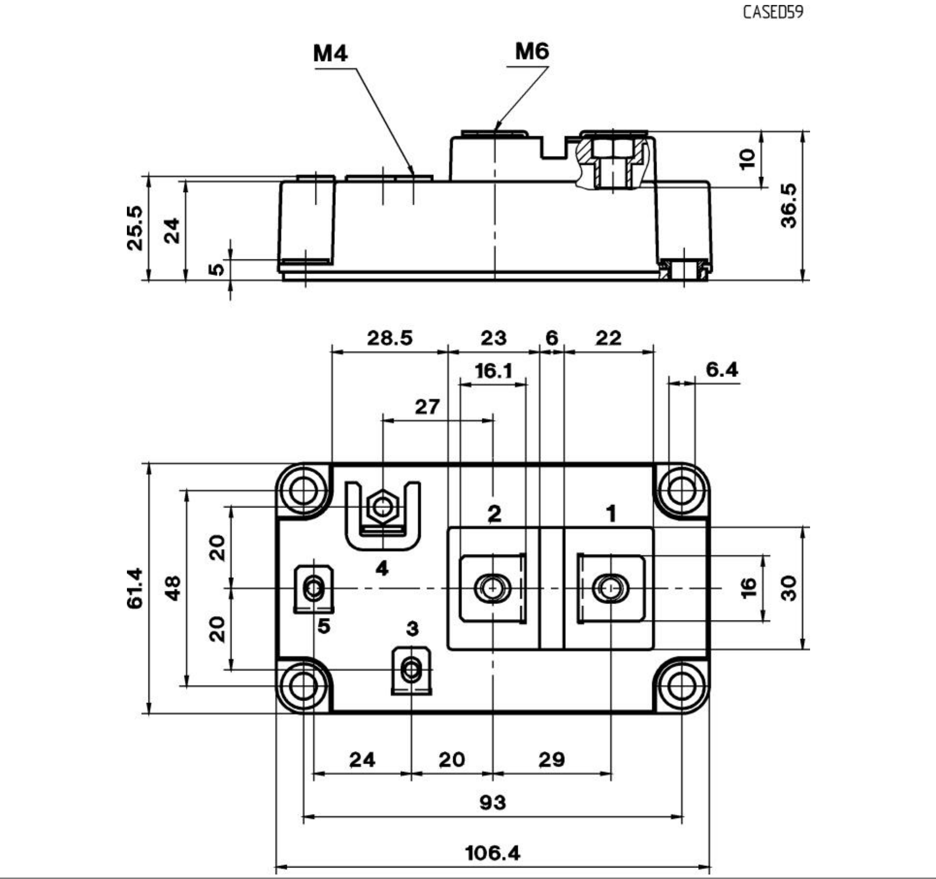


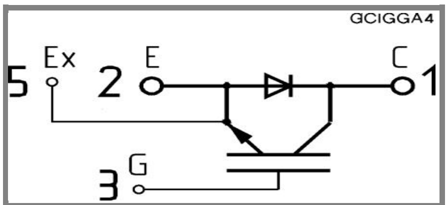
Fig. 13 Typ. CAL diode recovered charge

UL Recognized
File no. E 63 532

Dimensions in mm



Case D 59



Case D59 GA

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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